

# NB4N111K

## 3.3V Differential In 1:10 Differential Fanout Clock Driver with HCSL Level Output

### Description

The NB4N111K is a differential input clock 1 to 10 HCSL fanout buffer, optimized for ultra low propagation delay variation. The NB4N111K is designed with HCSL clock distribution for FBDIMM applications in mind.

Inputs can accept differential LVPECL, CML, or LVDS levels. Single-ended LVPECL, CML, LVCMOS or LVTTL levels are accepted with the proper  $V_{REFAC}$  supply (see Figures 5, 10, 11, 12, and 13). Clock input pins incorporate an internal  $50\ \Omega$  on die termination resistors. Outputs can interface with LVDS with proper termination (See Figure 15).

The NB4N111K specifically guarantees low output-to-output skews. Optimal design, layout, and processing minimize skew within a device and from device to device. System designers can take advantage of the NB4N111K's performance to distribute low skew clocks across the backplane or the motherboard.

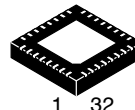
### Features

- Typical Input Clock Frequencies: 100, 133, 166, 200, 266, 333, and 400 MHz
- 340 ps Typical Rise and Fall Times
- 800 ps Typical Propagation Delay
- $A_{tpd}$  100 ps Maximum Propagation Delay Variation Per Each Differential Pair
- <1 ps RMS Additive Clock jitter
- Operating Range:  $V_{CC} = 3.0\text{ V}$  to  $3.6\text{ V}$  with  $V_{EE} = 0\text{ V}$
- Differential HCSL Output Level or LVDS with Proper Termination
- These are Pb-Free Devices



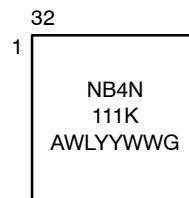
ON Semiconductor®

<http://onsemi.com>



QFN32  
MN SUFFIX  
CASE 488AM

### MARKING DIAGRAM\*



A = Assembly Site  
WL = Wafer Lot  
YY = Year  
WW = Work Week  
G = Pb-Free Package

\*For additional marking information, refer to Application Note AND8002/D.

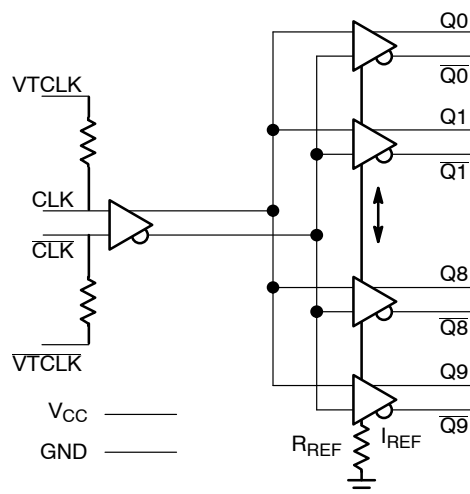
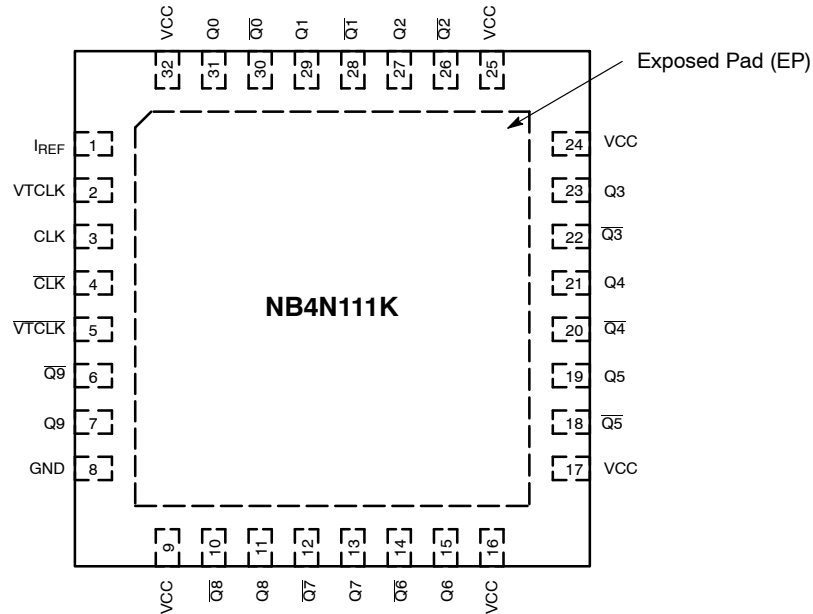


Figure 1. Pin Configuration (Top View)

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

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**Figure 2. Pinout Configuration (Top View)**

**Table 1. PIN DESCRIPTION**

| Pin                                      | Name                    | I/O                    | Description                                                                                                                                                                                                                                                       |
|------------------------------------------|-------------------------|------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1                                        | I <sub>REF</sub>        | Output                 | Output current programming pin. Connect to GND. (See Figure 9).                                                                                                                                                                                                   |
| 2, 5                                     | VTCLK,<br>VTCLK         | –                      | Internal 50 $\Omega$ Termination Resistor connection Pins. In the differential configuration when the input termination pins are connected to the common termination voltage, and if no signal is applied then the device may be susceptible to self-oscillation. |
| 3                                        | CLK                     | LVPECL Input           | CLOCK Input (TRUE)                                                                                                                                                                                                                                                |
| 4                                        | $\overline{\text{CLK}}$ | LVPECL Input           | CLOCK Input (INVERT)                                                                                                                                                                                                                                              |
| 8                                        | GND                     | –                      | Supply Ground. GND pin must be externally connected to power supply to guarantee proper operation.                                                                                                                                                                |
| 9, 16, 17, 24, 25, 32                    | V <sub>CC</sub>         | –                      | Positive Supply pins. V <sub>CC</sub> pins must be externally connected to a power supply to guarantee proper operation.                                                                                                                                          |
| 6, 10, 12, 14, 18, 20,<br>22, 26, 28, 30 | Q[09–0]                 | HCSL or<br>LVDS Output | Noninverted Clock Output. (For LVDS levels see Figure 15)                                                                                                                                                                                                         |
| 7, 11, 13, 15, 19, 21,<br>23, 27, 29, 31 | Q[09–0]                 | HCSL or<br>LVDS Output | Inverted Clock Output. (For LVDS levels see Figure 15)                                                                                                                                                                                                            |
| Exposed Pad                              | EP                      | GND                    | Exposed Pad. The thermally exposed pad (EP) on package bottom (see case drawing) must be attached to a sufficient heat-sinking conduit for proper thermal operation. (Note 1)                                                                                     |

1. The exposed pad must be connected to the circuit board ground.

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**Table 2. ATTRIBUTES**

| Characteristic                                         | Value                |
|--------------------------------------------------------|----------------------|
| Input Default State Resistors                          | None                 |
| ESD Protection Human Body Model                        | >2 kV                |
| Moisture Sensitivity (Note 2) QFN32                    | Level 1              |
| Flammability Rating Oxygen Index: 28 to 34             | UL 94 V-0 @ 0.125 in |
| Transistor Count                                       | 622                  |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test |                      |

2. For additional information, see Application Note AND8003/D.

**Table 3. MAXIMUM RATINGS** (Note 3)

| Symbol            | Parameter                                                 | Condition 1        | Condition 2    | Rating                                       | Unit         |
|-------------------|-----------------------------------------------------------|--------------------|----------------|----------------------------------------------|--------------|
| V <sub>CC</sub>   | Positive Power Supply                                     | GND = 0 V          |                | 6.0                                          | V            |
| V <sub>I</sub>    | Positive Input                                            | GND = 0 V          |                | GND – 0.3 ≤ V <sub>I</sub> ≤ V <sub>CC</sub> | V            |
| V <sub>INPP</sub> | Differential Input Voltage  CLK – $\overline{\text{CLK}}$ |                    |                | V <sub>CC</sub>                              | V            |
| I <sub>OUT</sub>  | Output Current                                            | Continuous Surge   |                | 50<br>100                                    | mA<br>mA     |
| T <sub>A</sub>    | Operating Temperature Range                               | QFN32              |                | –40 to +70                                   | °C           |
| T <sub>stg</sub>  | Storage Temperature Range                                 |                    |                | –65 to +150                                  | °C           |
| θ <sub>JA</sub>   | Thermal Resistance (Junction–to–Ambient) (Note 3)         | 0 lfpm<br>500 lfpm | QFN32<br>QFN32 | 31<br>27                                     | °C/W<br>°C/W |
| θ <sub>JC</sub>   | Thermal Resistance (Junction–to–Case)                     | 2S2P (Note 4)      | QFN32          | 12                                           | °C/W         |
| T <sub>sol</sub>  | Wave Solder Pb–Free                                       |                    |                | 265                                          | °C           |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

3. JEDEC standard 51–6, multilayer board – 2S2P (2 signal, 2 power).

4. JEDEC standard multilayer board – 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

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**Table 4. DC CHARACTERISTICS** ( $V_{CC} = 3.0\text{ V to }3.6\text{ V}$ ,  $T_A = -40^\circ\text{C to }+70^\circ\text{C}$  Note 5)

| Symbol    | Characteristic                             | Min  | Typ  | Max | Unit          |
|-----------|--------------------------------------------|------|------|-----|---------------|
| $I_{GND}$ | GND Supply Current (All Outputs Loaded)    | 70   | 98   | 120 | mA            |
| $I_{CC}$  | Power Supply Current (All Outputs Loaded)  |      |      | 300 | mA            |
| $I_{IH}$  | Input HIGH Current CLKx, $\overline{CLKx}$ |      | 2.0  | 150 | $\mu\text{A}$ |
| $I_{IL}$  | Input LOW Current CLKx, $\overline{CLKx}$  | -150 | -2.0 |     | $\mu\text{A}$ |

**DIFFERENTIAL INPUT DRIVEN SINGLE-ENDED** (Figures 5 and 7)

|          |                                                  |                |  |                |    |
|----------|--------------------------------------------------|----------------|--|----------------|----|
| $V_{th}$ | Input Threshold Reference Voltage Range (Note 6) | 1050           |  | $V_{CC} - 150$ | mV |
| $V_{IH}$ | Single-Ended Input HIGH Voltage                  | $V_{th} + 150$ |  | $V_{CC}$       | mV |
| $V_{IL}$ | Single-Ended Input LOW Voltage                   | GND            |  | $V_{th} - 150$ | mV |

**DIFFERENTIAL INPUTS DRIVEN DIFFERENTIALLY** (Figures 6 and 8)

|           |                                                    |      |  |               |    |
|-----------|----------------------------------------------------|------|--|---------------|----|
| $V_{IHD}$ | Differential Input HIGH Voltage                    | 1200 |  | $V_{CC}$      | mV |
| $V_{ILD}$ | Differential Input LOW Voltage                     | GND  |  | $V_{CC} - 75$ | mV |
| $V_{ID}$  | Differential Input Voltage ( $V_{IHD} - V_{ILD}$ ) | 75   |  | 2400          | mV |
| $V_{CMR}$ | Input Common Mode Range                            | 1163 |  | $V_{CC} - 75$ |    |

**HCSL OUTPUTS** (Figure 4)

|          |                     |      |     |     |    |
|----------|---------------------|------|-----|-----|----|
| $V_{OH}$ | Output HIGH Voltage | 600  | 740 | 900 | mV |
| $V_{OL}$ | Output LOW Voltage  | -150 | 0   | 150 | mV |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5. Input parameters vary 1:1 with  $V_{CC}$ . Measurements taken with all outputs loaded 50  $\Omega$  to GND, see Figure 9.

6.  $V_{th}$  is applied to the complementary input when operating in single ended mode.

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**Table 5. AC CHARACTERISTICS**  $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$ ,  $GND = 0 \text{ V}$ ;  $-40^{\circ}\text{C to } +70^{\circ}\text{C}$  (Note 7)

| Symbol                                 | Characteristic                                                                                                                  | Min | Typ | Max              | Unit           |
|----------------------------------------|---------------------------------------------------------------------------------------------------------------------------------|-----|-----|------------------|----------------|
| $V_{OUTPP}$                            | Output Voltage Amplitude (@ $V_{INPPmin}$ ) $f_{in} = 400 \text{ MHz}$                                                          |     | 725 | 1000             | mV             |
| $t_{PLH}$ ,<br>$t_{PHL}$               | Propagation Delay to (See Figure 3) $CLK/\overline{CLK}$ to $Qx/\overline{Qx}$                                                  | 550 | 800 | 1100             | ps             |
| $\Delta t_{PLH}$ ,<br>$\Delta t_{PHL}$ | Propagation Delay Variations Variation Per Each Diff Pair $CLK/\overline{CLK}$ to $Qx/\overline{Qx}$ (Note 8)<br>(See Figure 3) |     |     | 100              | ps             |
| $t_{SKEW}$                             | Duty Cycle Skew (Note 9)<br>Within-Device Skew<br>Device-to-Device Skew (Note 10)                                               |     |     | 20<br>100<br>150 | ps<br>ps<br>ps |
| $t_{JITTER}$                           | RMS Random Clock Jitter (Note 11) $f_{in} = 400 \text{ MHz}$                                                                    |     |     | 1                | ps             |
| $V_{cross}$                            | Absolute Crossing Magnitude Voltage                                                                                             | 250 |     | 550              | mV             |
| $\Delta V_{cross}$                     | Variation in Magnitude of $V_{cross}$                                                                                           |     |     | 150              | mV             |
| $t_r$ , $t_f$                          | Absolute Magnitude in Output Risetime and Falltime $Qx$ , $\overline{Qx}$<br>(From 175 mV to 525 mV)                            | 175 | 340 | 700              | ps             |
| $\Delta t_r$ , $\Delta t_f$            | Variation in Magnitude of Risetime and Falltime (Single-Ended)<br>(See Figure 4) $Qx$ , $\overline{Qx}$                         |     |     | 125              | ps             |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

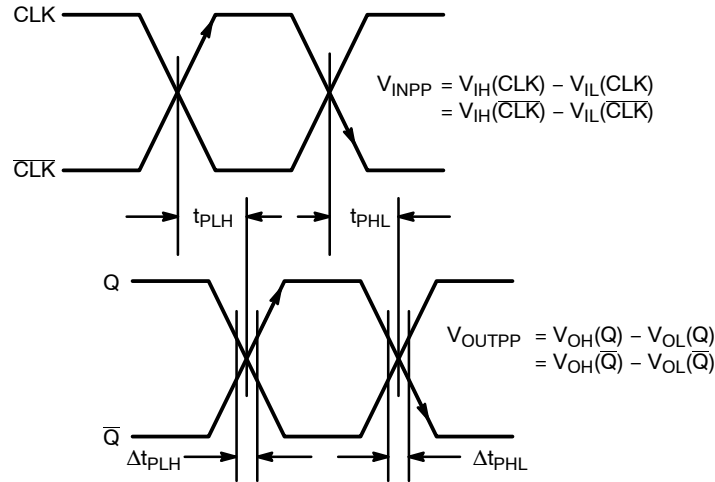
7. Measured by forcing  $V_{INPP}$  (MIN) from a 50% duty cycle clock source. Measurements taken with all outputs loaded  $50 \Omega$  to GND, see Figure 9. Typical gain is 20 dB.

8. Measured from the input pair crosspoint to each single output pair crosspoint across temp and voltage ranges.

9. Duty cycle skew is measured between differential outputs using the deviations of the sum of  $T_{pw-}$  and  $T_{pw+}$ .

10. Skew is measured between outputs under identical transition @ 400 MHz.

11. Additive RMS jitter with 50% duty cycle clock signal using phase noise integrated from 12 KHz to 33 MHz



**Figure 3. AC Reference Measurement**

# NB4N111K

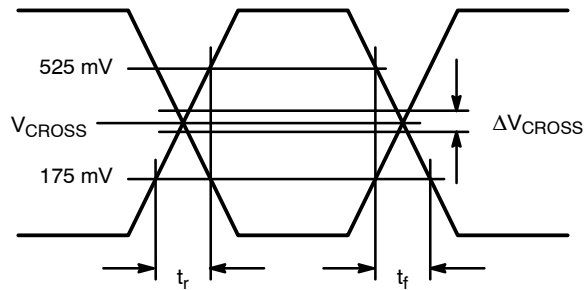


Figure 4. HCSL Output Parameter Characteristics

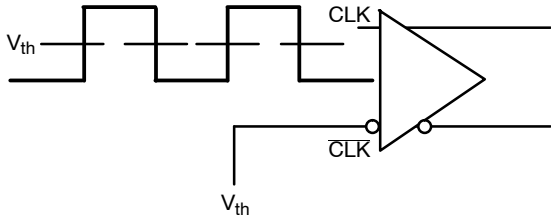


Figure 5. Differential Input Driven Single-Ended ( $V_{th} = V_{REFAC}$ )

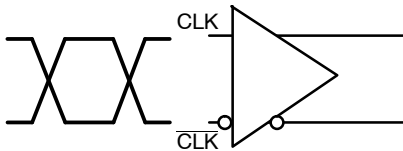


Figure 6. Differential Inputs Driven Differentially

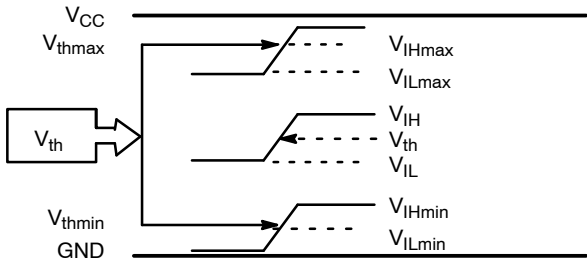


Figure 7.  $V_{th}$  Diagram

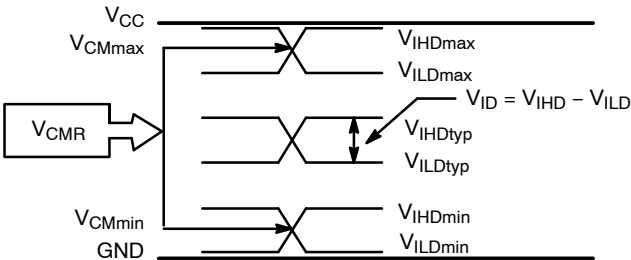
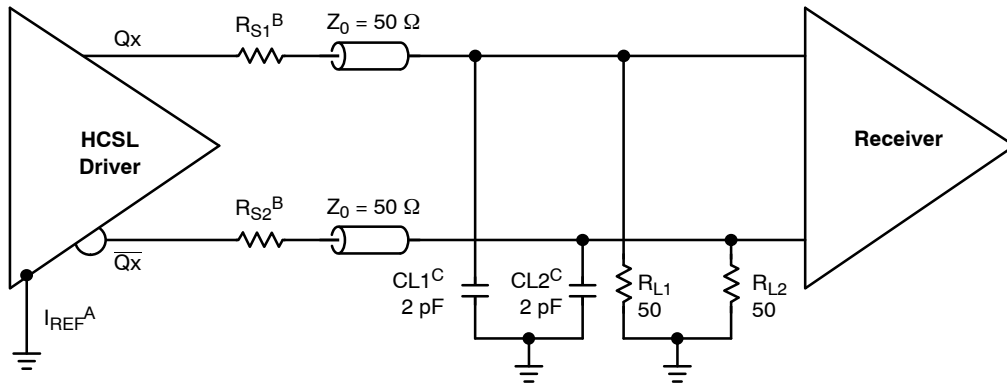


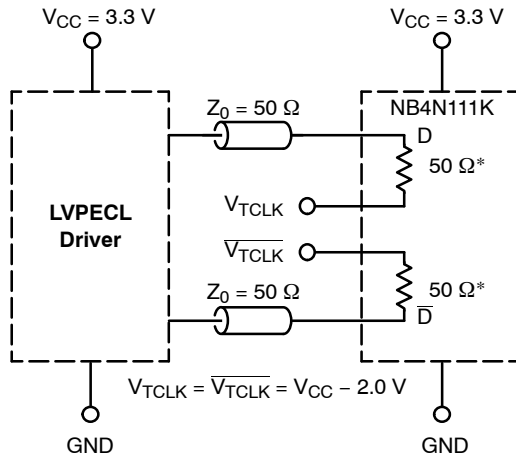
Figure 8.  $V_{CMR}$  Diagram

## NB4N111K



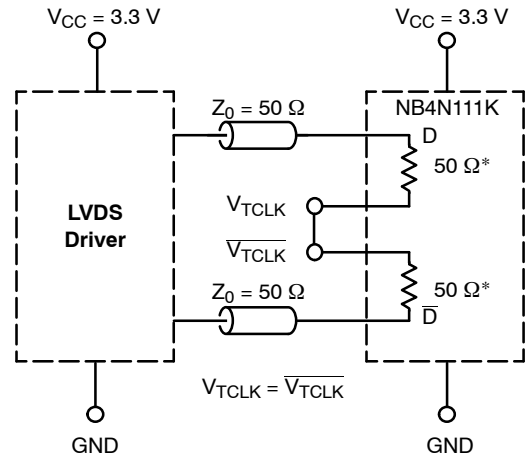
- A. Connect IREF pin to GND.
- B. RS1, RS2: 0  $\Omega$  for Test and Evaluation. Select to Minimizing Ringing.
- C. CL1, CL2: Receiver Input Simulation Load Capacitance Only.

**Figure 9. Typical Termination Configuration for Output Driver and Device Evaluation  $C_{Lx}$  for Test Only (Representing Receiver Input Loading); Not Added to Application**



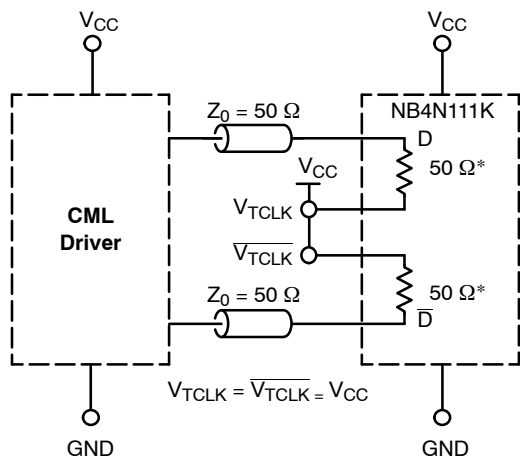
\*RTIN, Internal Input Termination Resistor

**Figure 10. LVPECL Interface**



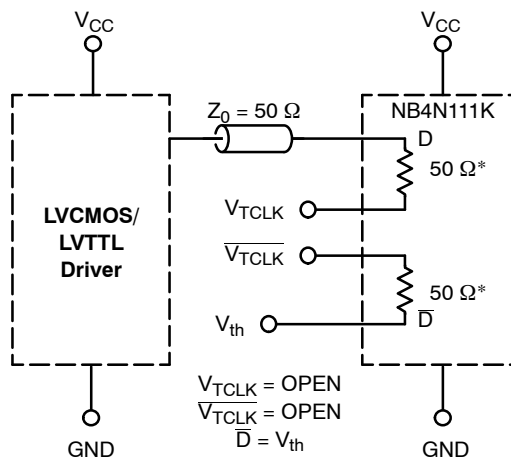
\*RTIN, Internal Input Termination Resistor

**Figure 11. LVDS Interface**

**NB4N111K**

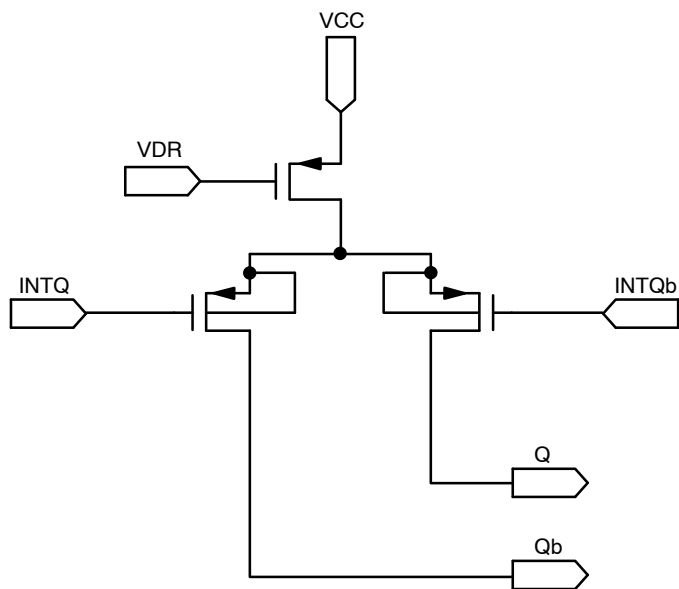
\*RTIN, Internal Input Termination Resistor

**Figure 12. Standard 50  $\Omega$  Load CML Interface**

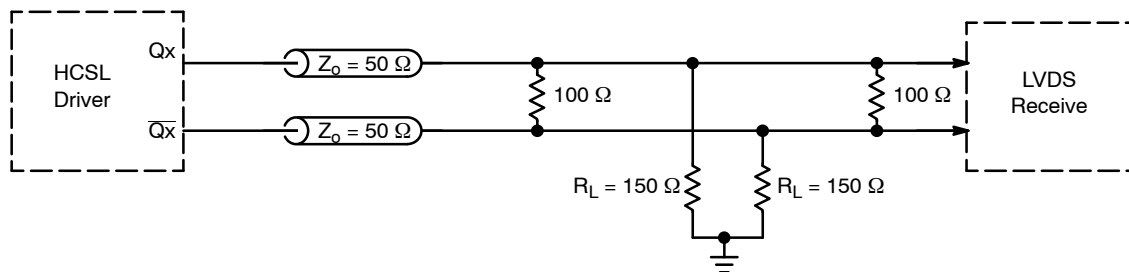


\*RTIN, Internal Input Termination Resistor

### Figure 13. LVCMOS/LVTTL Interface



### Figure 14. HCSL Output Structure



### Figure 15. HCSL Interface Termination to LVDS

## NB4N111K

### ORDERING INFORMATION

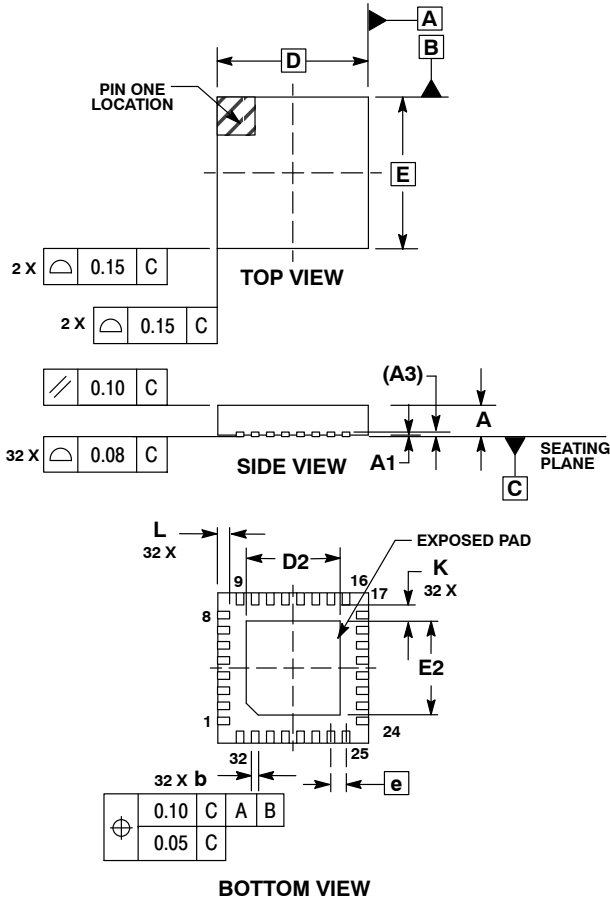
| Device        | Package            | Shipping <sup>†</sup> |
|---------------|--------------------|-----------------------|
| NB4N111KMNG   | QFN32<br>(Pb-Free) | 79 Units / Rail       |
| NB4N111KMNR4G | QFN32<br>(Pb-Free) | 1000 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NB4N111K

## PACKAGE DIMENSIONS

QFN32 5x5, 0.5P  
CASE 488AM-01  
ISSUE O

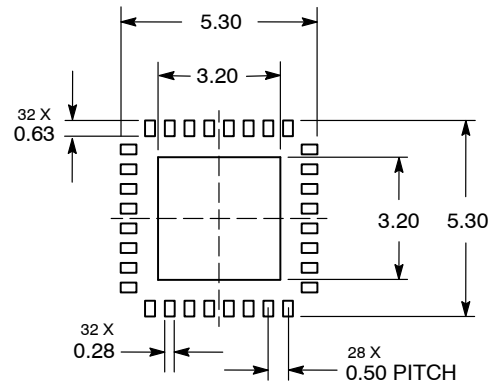


### NOTES:

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM TERMINAL
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS |       |       |
|-----|-------------|-------|-------|
|     | MIN         | NOM   | MAX   |
| A   | 0.800       | 0.900 | 1.000 |
| A1  | 0.000       | 0.025 | 0.050 |
| A3  | 0.200 REF   |       |       |
| b   | 0.180       | 0.250 | 0.300 |
| D   | 5.00 BSC    |       |       |
| D2  | 2.950       | 3.100 | 3.250 |
| E   | 5.00 BSC    |       |       |
| E2  | 2.950       | 3.100 | 3.250 |
| e   | 0.500 BSC   |       |       |
| K   | 0.200       | ---   | ---   |
| L   | 0.300       | 0.400 | 0.500 |

### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERM/D.

The products described herein (NB4N111k), may be covered by U.S. patents including 6,362,644. There may be other patents pending.

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NB4N111K/D

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В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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